Risk and Safety in Engineering

Prof. Dr. Michael Havbro Faber Swiss Federal Institute of Technology ETH Zurich, Switzerland



Contents of Today's Lecture

- Introduction to Classical Reliability Theory
- Reliability Analysis of Technical Components
- Example on Failure Rate Assessment
- Introduction to Reliability Analysis of Structural Components



During the second world war it became evident that the reliability of complex technical installations was a problem

As an example the modern warships at the time were only operational for attack/defence in about 60 % of the time

Similar effects were observed on the reliability of e.g. the V1 / V2 rocket systems – the first many launches were unsuccessful

These events were the real initiators of the reliability theory for technical components and systems



Initially the reliability theory was developed for systems with a large number of (semi-) identical components subject to the same exposure conditions

- electrical systems (bulbs, switches, ..)

and later on to

- nuclear power installations (valves, pipes, pumps, ..)
- chemical plants (pipes, pressure vessels, valves, pumps,..)
- manufacturing plants (pumps, compressors, conveyers,..)



For such systems the probability of a componential failure may be assessed in a frequentistic manner –

from observed failure rates

- number of failures per component operation hours

Due to the characteristics of the failure mechanism

a steady deterioration as function of time/use

for the considered components the main concern was centered around the statistical modelling of the time till failure



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For technical systems such as structures and structural components the classical reliability analysis is of limited use because

- all structural components are unique
- the failure mechanism tends to be related to extreme load events exceeding the residual capacity of the component – not the direct effect of deterioration alone

For such systems a different approach is thus required, namely

- an individual modelling of both the resistance as a function of time and the loading as a function of time



Classical Reliability Analysis Structural Reliability Analysis Data on time Distribution model Data on load Distribution models for time to failure T to failures characteristics for load S Data on material Distribution models characteristics for resistance R Estimation of distribution parameters Estimation of Statistics on time distribution parameters to failures T R and S Probability of R-S



The probability of failure for a component is defined by the

reliability function

where *T* is the time till failure and $F_T(t)$ is the cumulative distribution function

$$R_{T}(t) = 1 - F_{T}(t) = 1 - P(T \le t)$$

If the probability density $f_T(t)$ function is known the reliability function may be defined by

$$R_T(t) = 1 - \int_0^t f_T(\tau) d\tau = \int_t^\infty f_T(\tau) d\tau$$



The reliability function thus depends on the cumulative distribution function or the probability density function for the time till failure

Different types of probability distribution functions may be derived on the basis of physical arguments

An example is the Weibull distribution often used to describe the time till fatigue failure

Then the reliability function is given as

$$R_{T}(t) = 1 - F_{T}(t) = 1 - (1 - \exp\left[-(\frac{t}{k})^{\beta}\right]) = \exp\left[-(\frac{t}{k})^{\beta}\right], \qquad t \ge 0$$



Having defined the reliability function the mean time till failure may be derived as

which may be seen from (integration by parts)

$$E[T] = \int_{0}^{\infty} \tau \cdot f_{T}(\tau) d\tau = \int_{0}^{\infty} R_{T}(\tau) d\tau$$
$$E[T] = \int_{0}^{\infty} \tau f_{T}(\tau) dt = [t \cdot F_{T}(t)]_{0}^{\infty} - \int_{0}^{\infty} F_{T}(\tau) d\tau$$
$$= [t \cdot (1 - R_{T}(t))]_{0}^{\infty} - \int_{0}^{\infty} (1 - R_{T}(\tau)) d\tau$$
$$= [t]_{0}^{\infty} - [t \cdot R_{T}(t)]_{0}^{\infty} - [t]_{0}^{\infty} + \int_{0}^{\infty} R_{T}(\tau) d\tau$$
$$= \int_{0}^{\infty} R_{T}(\tau) d\tau - [t \cdot R_{T}(t)]_{0}^{\infty} = \int_{0}^{\infty} R_{T}(\tau) d\tau$$

 $\lim_{t\to\infty} \left[t\cdot R_T(t)\right]_0^\infty = 0$

provided that

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The probability that the component will fail in a given interval $[t, t + \delta t]$ is given by

 $P(t < T \le t + \delta t) = F_T(t + \delta t) - F_T(t) = R_T(t) - R_T(t + \delta t)$

The failure rate function z(t) is defined as the average rate of failures in a given time interval given that the component has not failed previously

$$z(t) = \frac{R_T(t) - R_T(t + \delta t)}{\delta t R_T(t)}$$







- The failure rate function is important z(t) for the planning of maintenance and z(t) inspections
- for constant failure rate functions there is no basis for inspection planning
- corrective maintenance
- for constant-strongly increasing failure rate functions the time of failure is "known"
- preventive maintenance

for constant-moderately increasing failure rate functions deterioration will be evident before failure

- condition control and condition based maintenance





constant-moderately increasing

Failure rates may be assessed on the basis of observations of failures in a given time interval

Preferably the failure rates are estimated by e.g. the method of maximum likelihood.

The uncertainty associated with the failure rate may then be quantified

Having additional information the uncertain failure rate may be updated

For exponential distributed failure times we have



$$z = \frac{n_f}{\tau \cdot n_i}$$

 $f_{Z}'(z)$

$$f_{Z}^{"}(z) = \frac{L(\boldsymbol{\tau} | z) \cdot f_{Z}^{'}(z)}{\int_{0}^{\infty} L(\boldsymbol{\tau} | z) \cdot f_{Z}^{'}(z) dz}$$

$$L(\mathbf{\tau} | z) = \prod_{i=1}^{n} z \exp(-z \cdot \tau_i)$$

It is assumed that observed times till failures are available and the failure rate shall be determined

The probability density function for the time till failure is

 $f_T(t) = z \exp(-z \cdot t)$

The log-Likelihood function is

$$l(\mathbf{t}|z) = \sum_{i=1}^{10} \left(\ln(z) - z \cdot t_i \right)$$

A failure rate equal to 0.95 is obtained

| Pump | Time till failure |
|------|-------------------|
| 1 | 0.24 |
| 2 | 3.65 |
| 3 | 1.25 |
| 4 | 0.2 |
| 5 | 1.79 |
| 6 | 0.6 |
| 7 | 0.74 |
| 8 | 1.43 |
| 9 | 0.53 |
| 10 | 0.13 |

Assume now that only data on failure up till the first year are available

In this case a failure rate equal to 2.45 is obtained

| Pump | Time till failure |
|------|-------------------|
| 1 | 0.24 |
| 2 | 3.65 |
| 3 | 1.25 |
| 4 | 0.2 |
| 5 | 1.79 |
| 6 | 0.6 |
| 7 | 0.74 |
| 8 | 1.43 |
| 9 | 0.53 |
| 10 | 0.13 |



Assume now that only data on failure up till the first year are available

By only observing a limited time interval in fact the sample can be considered to be censored

However, by using a modified likelihood function

$$l(\mathbf{t}|z) = n_n \ln(1 - F_T(1)) + \sum_{i=1}^{n_f} \ln(z) - z \quad t_i = -n_n z + \sum_{i=1}^{n_f} \ln(z) - z \quad t_i$$

an estimate for the failure rate equal to 0.94 is achieved – very close to the correct

| Pump | Time till failure |
|------|-------------------|
| 1 | 0.24 |
| 2 | 3.65 |
| 3 | 1.25 |
| 4 | 0.2 |
| 5 | 1.79 |
| 6 | 0.6 |
| 7 | 0.74 |
| 8 | 1.43 |
| 9 | 0.53 |
| 10 | 0.13 |

Using all data the Maximum Likelihood Method (MLM) provides us also with the statistical uncertainty by which the failure rate is associated

It is assumed that 3 new observations are made available

| Pump | Time till failure |
|------|----------------------|
| 1 | 3.2 |
| 2 | 3.5 |
| 3 | 3.3 |



Prior: Normal distributed Mean = 0.95 Standard Deviation = 0.42

The likelihood of the 3 observations is

$$L(\mathbf{t}|z) = \prod_{i=1}^{3} z \exp(-zx_i)$$

The posterior probability density function for the failure rate is thus

$$f_{Z}^{"}(z|\mathbf{t}) = \frac{1}{c}L(\mathbf{t}|z)f_{Z}^{'}(z)$$



Prior: Normal distributed Mean = 0.95 Standard Deviation = 0.42

Finally the failure probability may be determined

 $P_F(T|z) = 1 - \exp(-zT)$

However – as the failure rate is uncertain we must integrate out over the probability density function of the failure rate

$$P_F(T) = 1 - \int_0^\infty \exp(-zT) f_Z(z) dz$$

Using the prior probability density function the failure probability is equal to 0.61

Using the posterior the failure probability is equal to 0.38



Reliability of structures cannot be assessed through failure rates because

- Structures are unique in nature
- Structural failures normally take place due to extreme loads exceeding the residual strength

Therefore in structural reliability models are established for resistances R and loads S individually and the structural reliability is assessed through the probability of failure



$$P_f = P(R - S \le 0)$$

If only the resistance is uncertain the failure probability may be assessed by

If also the load is uncertain we have

where it is assumed that the load and the resistance are independent

This is called the

"Fundamental Case"

$$P_f = P(R \le s) = F_R(s) = P(R / s \le 1)$$
$$P_f = P(R \le S) = P(R - S \le 0) = \int_{-\infty}^{\infty} F_R(x) f_S(x) dx$$





| The safety margin M is | M = R - S |
|------------------------|-----------|
|------------------------|-----------|

In case R and S are Normal distributed the safety margin M is also Normal distributed

The failure probability is

with the mean value of M

and standard deviation of M

The failure probability is then

where the reliability index is

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$$P_F = P(R - S \le 0) = P(M \le 0)$$
$$\mu_M = \mu_R - \mu_S$$
$$\sigma_M = \sqrt{\sigma_R^2 + \sigma_S^2}$$
$$P_F = \Phi(\frac{0 - \mu_M}{\sigma_M}) = \Phi(-\beta)$$

 $\beta = \mu_M / \sigma_M$

The Normal distributed safety margin M





In the general case the resistance and the load may be defined in terms of functions where X are basic random variables $R = f_1(\mathbf{X})$ $S = f_2(\mathbf{X})$

and the safety margin as

where g(x) is called the

limit state function

failure occurs when

 $M = R - S = f_1(\mathbf{X}) - f_2(\mathbf{X}) = g(\mathbf{X})$

 $g(\mathbf{x}) \leq 0$



Setting g(x)=0 defines a (n-1) dimensional surface in the space spanned by the n basic variables *X*

This is the failure surface separating the sample space of X into a safe domain and a failure domain

The failure probability may in general terms be written as



 $P_F = \int_{g(x) \le 0} f_{\mathbf{X}}(\mathbf{x}) d\mathbf{x}$

